

AP10N60W-VB Datasheet

N-Channel 600V (D-S) Super Junction MOSFET

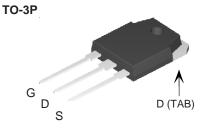
PRODUCT SUMMARY						
V _{DS} (V) at T _J max.	650					
R _{DS(on)} at 25 °C (Ω)	$V_{GS} = 10 V$	0.38				
Q _g max. (nC)	38					
Q _{gs} (nC)	4					
Q _{gd} (nC)	4.2					
Configuration	Single					

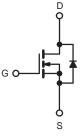
FEATURES

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Q_a)
- Avalanche energy rated (UIS)

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T C	= 25 °C, unl	less otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	600	- V	
Gate-Source Voltage			V _{GS}	± 30		
Continuous Drain Current (T _J = 150 °C)	V _{GS} at 10 V	T _C = 25 °C	- I _D -	11		
		$T_{C} = 25 \text{ °C}$ $T_{C} = 100 \text{ °C}$		9.7	А	
Pulsed Drain Current ^a			I _{DM}	50		
Linear Derating Factor				1.67/1.5/0.3	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	132	mJ	
Maximum Power Dissipation			PD	83/83/31	W	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C	
Drain-Source Voltage Slope	T _J = 125 °C		B (/ 1)	50		
Reverse Diode dV/dt ^d			dV/dt	3.1	V/ns	
Soldering Recommendations (Peak Temperature) ^c	for 10 s			300	°C	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b. $V_{DD} = 50$ V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 4.5 A.

c. 1.6 mm from case.

d. $I_{SD} \leq I_D$, dI/dt = 100 A/µs, starting T_J = 25 °C.





THERMAL RESISTANCE RATI	NGS								
PARAMETER	SYMBOL	TYP.		MAX.		UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 60			°0.00				
Maximum Junction-to-Case (Drain)	R _{thJC}	- 0.6				°C/W			
SPECIFICATIONS ($T_J = 25 \ ^{\circ}C$, u	Inless otherwi	se noted)			T	1	1	1	
PARAMETER	SYMBOL	TES	CONDIT	IONS	MIN.	TYP.	MAX.	UNIT	
Static									
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D =	250 µA	600	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	$I_D = 1 \text{ mA}$	-	0.65	-	V/°C	
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	$V_{GS}, I_D =$	250 µA	2	-	4	V	
	$V_{GS} = \pm 20 V$		V	-	-	± 100	nA		
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 30 \text{ V}$			-	-	± 1	μA	
Zero Gate Voltage Drain Current		V _{DS} =	650 V, V _G	_{iS} = 0 V	-	-	1		
	I _{DSS}	V _{DS} = 520 V	$V_{DS} = 520 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125 \text{ °C}$			-	10	μA	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V		I _D = 5 A	-	0.38	-	Ω	
Forward Transconductance		V _{DS}	= 30 V, I _D	= 5 A	-	16	-	S	
Dynamic	•	•						I	
Input Capacitance	C _{iss}	$V_{GS} = 0 V,$ $V_{DS} = 100 V,$ f = 1 MHz		-	680	-	pF		
Output Capacitance	C _{oss}			-	140	-			
Reverse Transfer Capacitance	C _{rss}			-	5	-			
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	- V _{DS} = 0 V to 520 V, V _{GS} = 0 V		-	63	-			
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	113	-			
Total Gate Charge	Qg	V _{GS} = 10 V I _D = 5 A, V _{DS} = 520 V			-	38	56		
Gate-Source Charge	Q _{gs}			-	4	-	nC		
Gate-Drain Charge	Q _{gd}				-	4.5	-	1	
Turn-On Delay Time	t _{d(on)}	V_{DD} = 520 V, I _D = 5 A, V _{GS} = 10 V, R _g = 9.1 Ω		-	13	25	- ns		
Rise Time	t _r			-	11	35			
Turn-Off Delay Time	t _{d(off)}			-	81	90			
Fall Time	t _f			-	25	40			
Gate Input Resistance	R _g	f = 1 MHz, open drain		-	3.5	-	Ω		
Drain-Source Body Diode Characteristi	cs								
Continuous Source-Drain Diode Current	۱ _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	11	A		
Pulsed Diode Forward Current	I _{SM}			-	-	55			
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 5 A, V _{GS} = 0 V		-	-	1.5	V		
Reverse Recovery Time	t _{rr}	<u> </u>	-		-	270	-	ns	
Reverse Recovery Charge	Q _{rr}	$T_J = 25 \text{ °C}, I_F = I_S = 5 \text{ A},$ dI/dt = 100 A/ μ s, V _R = 400 V		-	3.3	-	μC		
Reverse Recovery Current	I _{RRM}			_	30	_	A		

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

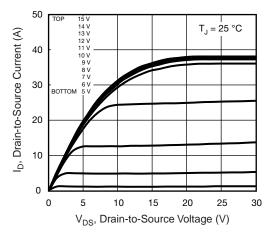


Fig. 1 - Typical Output Characteristics

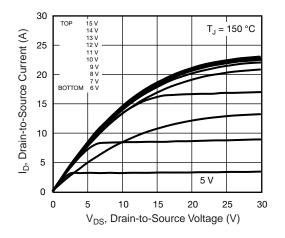


Fig. 2 - Typical Output Characteristics

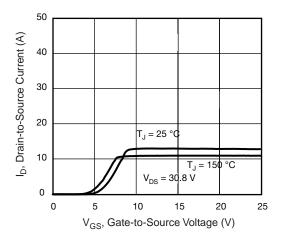


Fig. 3 - Typical Transfer Characteristics

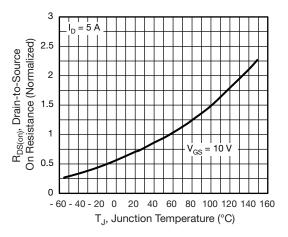


Fig. 4 - Normalized On-Resistance vs. Temperature

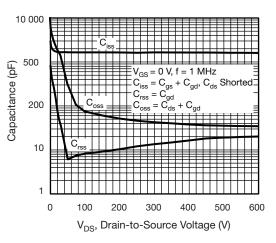


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

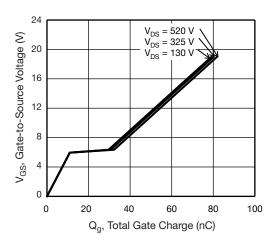


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

AP10N60W-VB



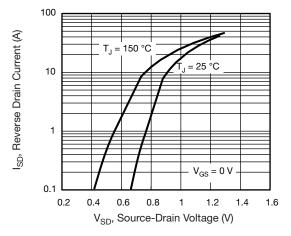
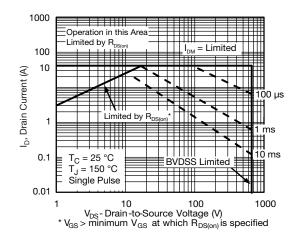


Fig. 7 - Typical Source-Drain Diode Forward Voltage





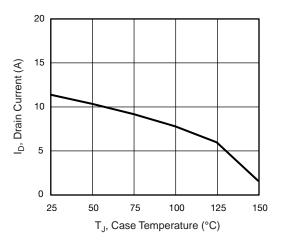


Fig. 9 - Maximum Drain Current vs. Case Temperature

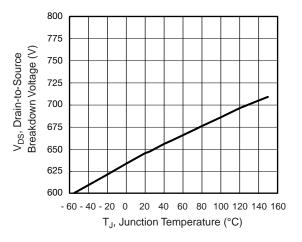


Fig. 10 - Temperature vs. Drain-to-Source Voltage

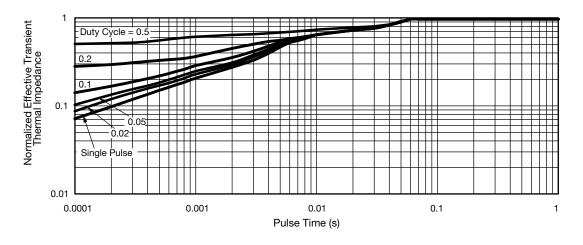


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



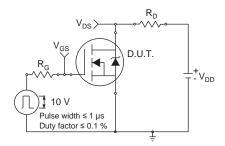


Fig. 12 - Switching Time Test Circuit

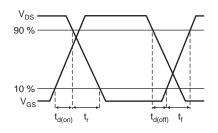


Fig. 13 - Switching Time Waveforms

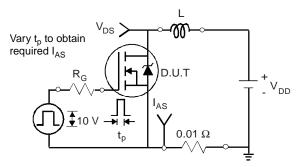


Fig. 14 - Unclamped Inductive Test Circuit

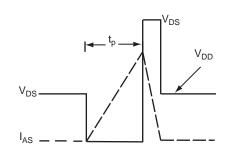


Fig. 15 - Unclamped Inductive Waveforms

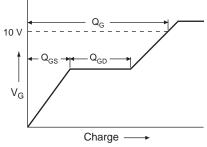


Fig. 16 - Basic Gate Charge Waveform

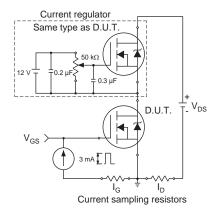
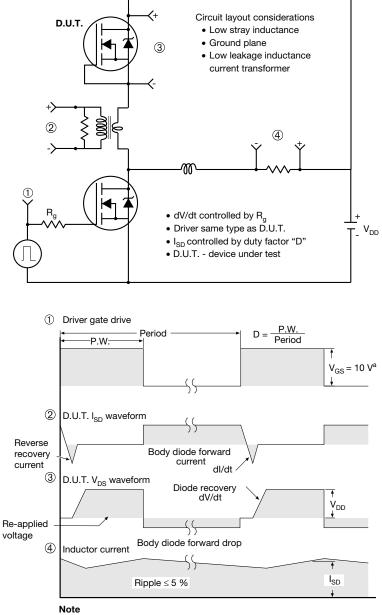


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

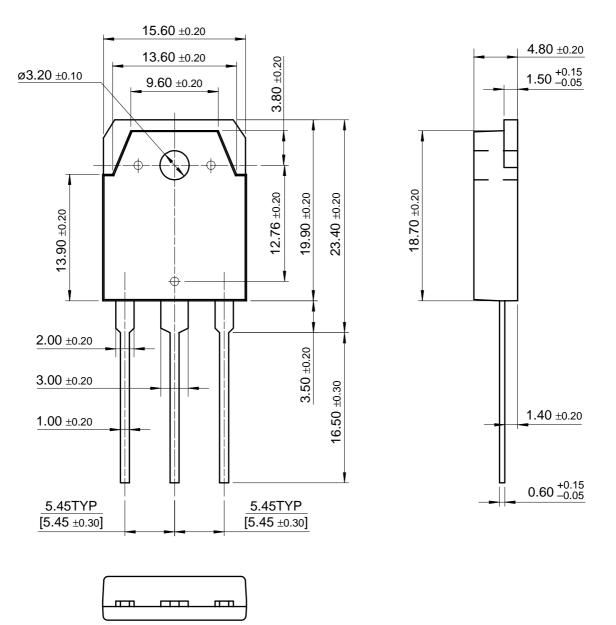


a. $V_{GS} = 5 V$ for logic level devices

Fig. 18 - For N-Channel



TO-3P





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